

Notice of References Cited	Application/Control No. 09/839,972		Applicant(s)/Patent Under Reexamination BODNAR ET AL.	
	Examiner Huy Q. Phan		Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,934,698 B2	08-2005	Judd et al.	707/1
*	C	US-7,015,806 B2	03-2006	Naidoo et al.	340/531
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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